

BFP720FESD

SiGe:C NPN RF bipolar transistor



Product description

The BFP720FESD is a wideband RF heterojunction bipolar transistor (HBT) with an integrated ESD protection.



Feature list

- Unique combination of high end RF performance and robustness: 21 dBm maximum RF input power, 2 kV HBM ESD hardness
- High transition frequency f_T = 45 GHz to enable low noise figure at high frequencies: NF_{min} = 0.8 dB at 5.5 GHz, 3 V, 5 mA
- High gain $G_{\rm ms}$ = 22 dB at 5.5 GHz, 3 V, 15 mA
- *OIP*₃ = 21 dBm at 5.5 GHz, 3 V, 15 mA

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Potential applications

- Wireless communications: WLAN, WiMax and UWB
- Satellite communication systems: GNSS navigation systems (GPS, GLONASS, BeiDou, Galileo), satellite radio (SDARs, DAB) and C-band LNB
- Multimedia applications such as portable TV, CATV and FM radio
- ISM applications like RKE, AMR and Zigbee, as well as for emerging wireless applications

Device information

Table 1 Part information

Product name / Ordering code	Package	Pin co	Pin configuration				Pieces / Reel
BFP720FESD / BFP720FESDH6327XTSA1	TSFP-4-1	1 = B	2 = E	3 = C	4 = E	T3s	3000

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions



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Absolute maximum ratings

1 Absolute maximum ratings

Table 2Absolute maximum ratings at $T_A = 25$ °C (unless otherwise specified)

Parameter	Symbol	Va	lues	Unit	Note or test condition	
		Min.	Max.			
Collector emitter voltage	V _{CEO}	-	4.2	V	Open base	
			3.7		T _A = -55 °C, open base	
Collector base voltage ¹⁾	V _{CBO}		4.9		Open emitter	
			4.4		$T_{\rm A}$ = -55 °C, open emitter	
Collector emitter voltage ²⁾	nitter voltage ²⁾ V _{CES}	4.2		E-B short circuited		
			3.7		<i>T</i> _A = -55 °C,	
					E-B short circuited	
Base current	I _B	-10	3	mA	-	
Collector current	I _C	-	30			
RF input power	P _{RFin}	-	21	dBm		
ESD stress pulse	V _{ESD}	-2	2	kV	HBM, all pins, acc. to JESD22-A114	
Total power dissipation ³⁾	P _{tot}	-	100	mW	<i>T</i> _S ≤ 109 °C	
Junction temperature	TJ	-	150	°C	-	
Storage temperature	7 _{Stg}	-55				

Attention: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the integrated circuit.

¹ V_{CBO} is similar to V_{CEO} due to design.

 $^{^{2}}$ V_{CES} is identical to V_{CEO} due to design.

³ $T_{\rm S}$ is the soldering point temperature. $T_{\rm S}$ is measured on the emitter lead at the soldering point of the PCB.



Thermal characteristics

2 Thermal characteristics

Table 3Thermal resistance

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Junction - soldering point	R _{thJS}	-	405	-	K/W	-

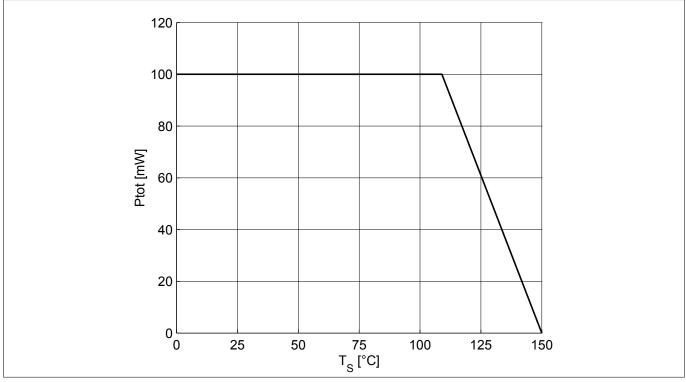


Figure 1

Total power dissipation $P_{tot} = f(T_S)$



Electrical characteristics

3 Electrical characteristics

3.1 DC characteristics

Table 4DC characteristics at $T_A = 25 \degree C$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.	-	
Collector emitter breakdown voltage	V _{(BR)CEO}	4.2	4.7	-	V	$I_{\rm C} = 1 \text{ mA}, I_{\rm B} = 0,$ open base
Collector emitter leakage current	I _{CES}	-	-	400 1)	nA	V _{CE} = 2 V, V _{BE} = 0, E-B short circuited
Collector base leakage current	I _{CBO}			400 ¹⁾		$V_{CB} = 2 V, I_E = 0,$ open emitter
Emitter base leakage current	I _{EBO}			10 ¹⁾	μA	$V_{\rm EB}$ = 0.5 V, $I_{\rm C}$ = 0, open collector
DC current gain	h _{FE}	160	250	400		V_{CE} = 3 V, I_{C} = 15 mA, pulse measured

3.2 General AC characteristics

Table 5General AC characteristics at $T_A = 25 \text{ °C}$

Parameter	Symbol		Values			Note or test condition
		Min.	Тур.	Max.		
Transition frequency	f _T	-	45	-	GHz	$V_{CE} = 3 V, I_{C} = 15 mA,$ f = 1 GHz
Collector base capacitance	C _{CB}		0.05		pF	$V_{CB} = 3 V, V_{BE} = 0,$ f = 1 MHz, emitter grounded
Collector emitter capacitance	C _{CE}		0.35			V _{CE} = 3 V, V _{BE} = 0, f = 1 MHz, base grounded
Emitter base capacitance	C _{EB}		0.4			$V_{EB} = 0.4 \text{ V}, V_{CB} = 0,$ f = 1 MHz, collector grounded

Datasheet

¹ Maximum values not limited by the device but by the short cycle time of the 100% test.



Electrical characteristics

3.3 Frequency dependent AC characteristics

Measurement setup is a test fixture with Bias-T's in a 50 Ω system, T_A = 25 °C.

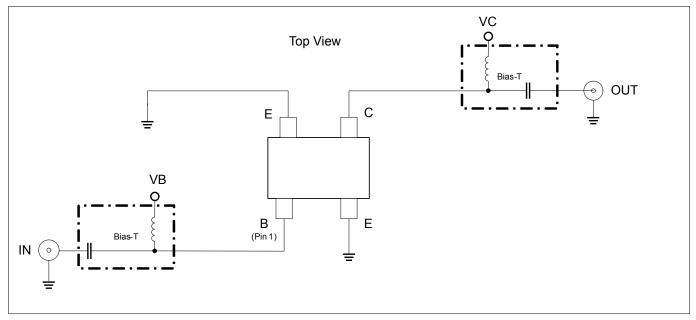


Figure 2 Testing circuit

Table 6AC characteristics, $V_{CE} = 3 V, f = 150 MHz$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ms}	-	38.5	-	dB	I _C = 15 mA
Transducer gain	S ₂₁ ²		30.5			
Noise figure						
Minimum noise figure	NF _{min}	-	0.5	-	dB	I _C = 5 mA
Associated gain	G _{ass}		29			
Linearity						
• 3rd order intercept point at output	OIP ₃	-	21.5	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$
• 1 dB gain compression point at output	OP _{1dB}		6			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$



Electrical characteristics

Table 7AC characteristics, $V_{CE} = 3 V, f = 450 MHz$

Parameter	Symbol	Values			Unit	Note or test conditior		
		Min.	Тур.	Max.				
Power gain								
Maximum power gain	G _{ms}	-	33.5	-	dB	I _C = 15 mA		
Transducer gain	$ S_{21} ^2$		30					
Noise figure								
Minimum noise figure	NF _{min}	-	0.5	-	dB	I _C = 5 mA		
Associated gain	G _{ass}		27.5					
Linearity								
• 3rd order intercept point at output	OIP ₃	-	21.5	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \Omega$		
• 1 dB gain compression point at output	OP _{1dB}		6			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$		

Table 8AC characteristics, $V_{CE} = 3 V, f = 900 MHz$

Parameter	Symbol	Values			Unit	Note or test condition	
		Min.	Тур.	Max.			
Power gain							
Maximum power gain	G _{ms}	_	30.5	-	dB	I _C = 15 mA	
Transducer gain	S ₂₁ ²		28.5				
Noise figure							
Minimum noise figure	NF _{min}	-	0.55	-	dB	I _C = 5 mA	
Associated gain	G _{ass}		25.5				
Linearity							
• 3rd order intercept point at output	OIP ₃	_	22	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$	
• 1 dB gain compression point at output	OP _{1dB}		6.5			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$	

Table 9AC characteristics, $V_{CE} = 3 V, f = 1.5 GHz$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ms}	_	28	-	dB	I _C = 15 mA
Transducer gain	$ S_{21} ^2$		26			
Noise figure						
Minimum noise figure	NF _{min}	_	0.55	-	dB	I _C = 5 mA
Associated gain	G _{ass}		23.5			
Linearity						
• 3rd order intercept point at output	OIP ₃	_	22	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$
• 1 dB gain compression point at output	OP _{1dB}		7			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$



Electrical characteristics

Table 10AC characteristics, $V_{CE} = 3 V, f = 1.9 GHz$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ms}	_	27	-	dB	I _C = 15 mA
Transducer gain	$ S_{21} ^2$		25			
Noise figure						
Minimum noise figure	NF _{min}	_	0.55	-	dB	I _C = 5 mA
Associated gain	G _{ass}		22.5			
Linearity						
• 3rd order intercept point at output	OIP ₃	-	22	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$
• 1 dB gain compression point at output	OP _{1dB}		7			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$

Table 11AC characteristics, $V_{CE} = 3 V, f = 2.4 GHz$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ms}	_	26	-	dB	I _C = 15 mA
Transducer gain	$ S_{21} ^2$		23.5			
Noise figure						
Minimum noise figure	NF _{min}	_	0.6	-	dB	I _C = 5 mA
Associated gain	G _{ass}		21			
Linearity						
• 3rd order intercept point at output	OIP ₃	-	22	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$
• 1 dB gain compression point at output	OP _{1dB}		7			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$

Table 12AC characteristics, $V_{CE} = 3 V, f = 3.5 GHz$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ms}	_	24.5	-	dB	I _C = 15 mA
Transducer gain	S ₂₁ ²		20.5			
Noise figure						
Minimum noise figure	NF _{min}	_	0.65	-	dB	I _C = 5 mA
Associated gain	G _{ass}		19			
Linearity						
• 3rd order intercept point at output	OIP ₃	_	21.5	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$
• 1 dB gain compression point at output	OP _{1dB}		7			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$



Electrical characteristics

Table 13AC characteristics, $V_{CE} = 3 V, f = 5.5 GHz$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ms}	_	22	-	dB	I _C = 15 mA
Transducer gain	$ S_{21} ^2$		17			
Noise figure						
Minimum noise figure	NF _{min}	_	0.8	-	dB	I _C = 5 mA
Associated gain	G _{ass}		16			
Linearity						
• 3rd order intercept point at output	OIP ₃	_	21	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \Omega$
• 1 dB gain compression point at output	OP _{1dB}		7			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$

Table 14AC characteristics, $V_{CE} = 3 V, f = 10 GHz$

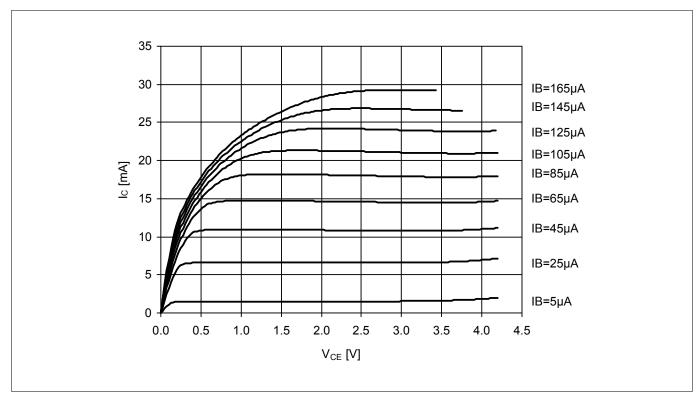
Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain						
Maximum power gain	G _{ma}	-	15	-	dB	I _C = 15 mA
Transducer gain	$ S_{21} ^2$		11			
Noise figure						
Minimum noise figure	NF _{min}	_	1.3	-	dB	I _C = 5 mA
Associated gain	G _{ass}		10			
Linearity						
• 3rd order intercept point at output	OIP ₃	_	20	-	dBm	$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$
• 1 dB gain compression point at output	OP _{1dB}		6			$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ $I_{\rm C} = 15 \ \rm{mA}$

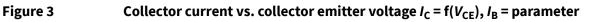
Note: $G_{ms} = IS_{21} / S_{12} I$ for k < 1; $G_{ma} = IS_{21} / S_{12} I(k - (k^2 - 1)^{1/2})$ for k > 1. In order to get the NF_{min} values stated in this chapter the test fixture losses have been subtracted from all measured results. OIP₃ value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.2 MHz to 12 GHz.



Electrical characteristics

3.4 Characteristic DC diagrams





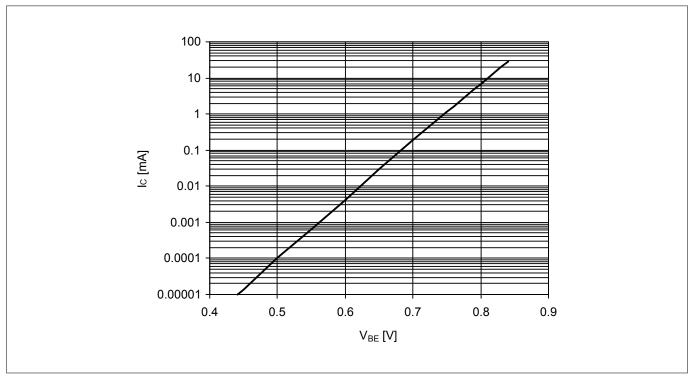
 $I_{c} [mA]$

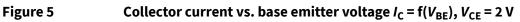


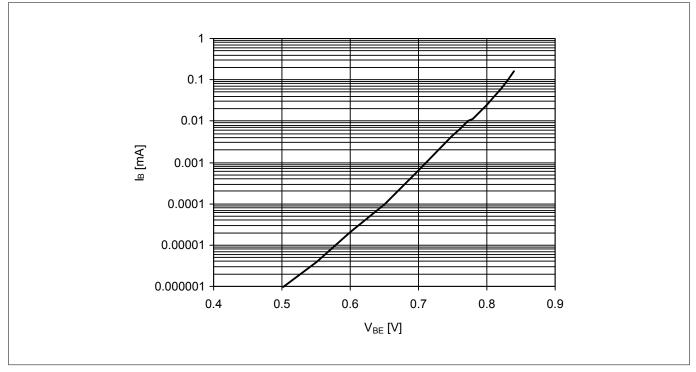
DC current gain $h_{FE} = f(I_C), V_{CE} = 3 V$



Electrical characteristics





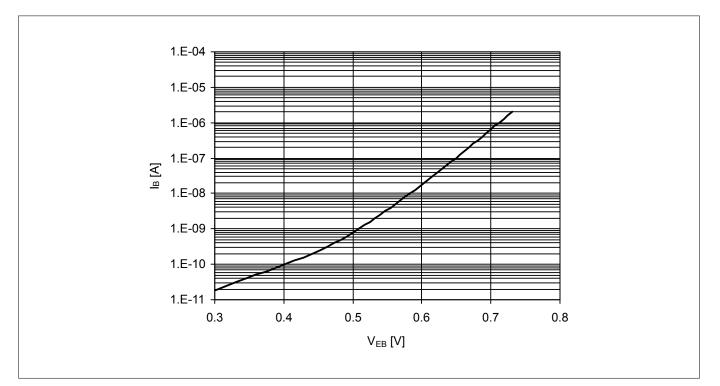




Base current vs. base emitter forward voltage $I_B = f(V_{BE})$, $V_{CE} = 2 V$



Electrical characteristics



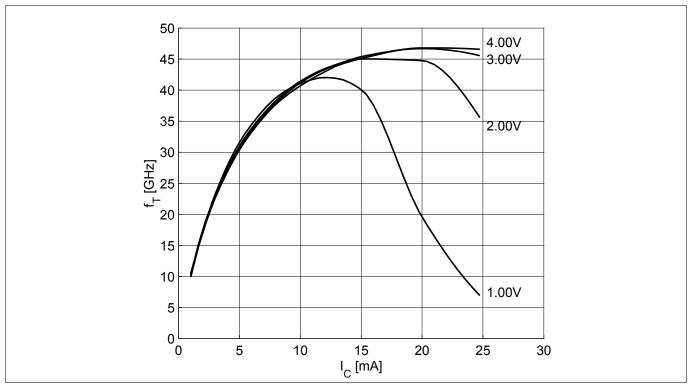


Base current vs. base emitter reverse voltage $I_{\rm B}$ = f($V_{\rm EB}$), $V_{\rm CE}$ = 2 V

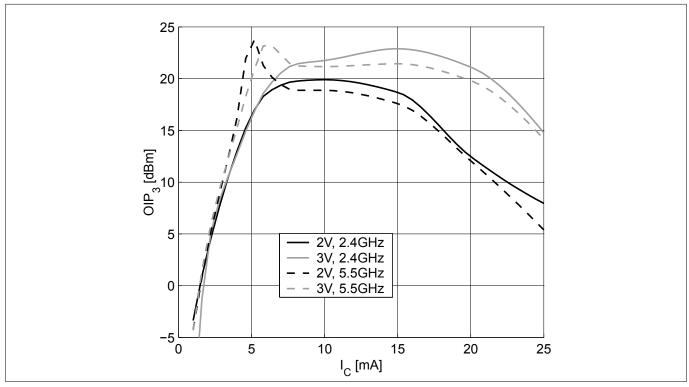
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Electrical characteristics

3.5 Characteristic AC diagrams







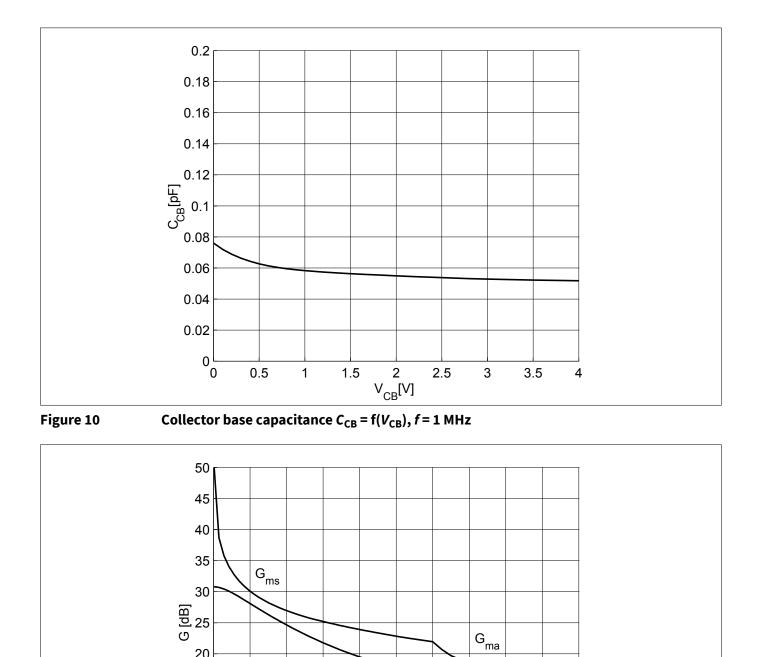


3rd order intercept point $OIP_3 = f(I_C), Z_S = Z_L = 50 \Omega, V_{CE}, f = parameters$

Datasheet



Electrical characteristics





Gain G_{ma} , G_{ms} , $|S_{21}|^2 = f(f)$, $V_{CE} = 3 V$, $I_C = 15 mA$

3

4

2

|S₂₁|²

20

15

10

5

0 ^L 0

1

Datasheet

10

9

8

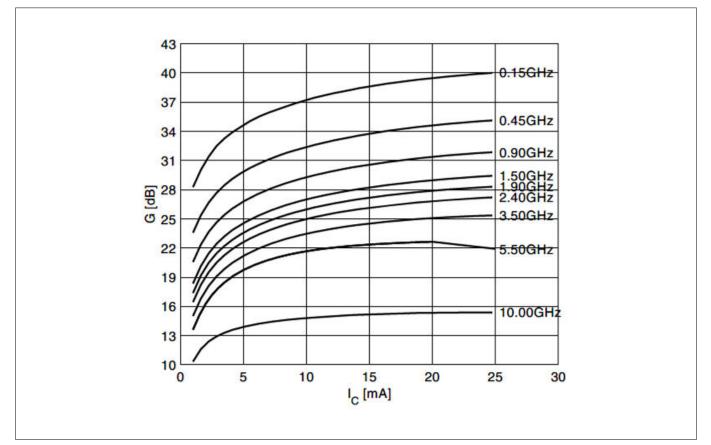
5 f [GHz]

6

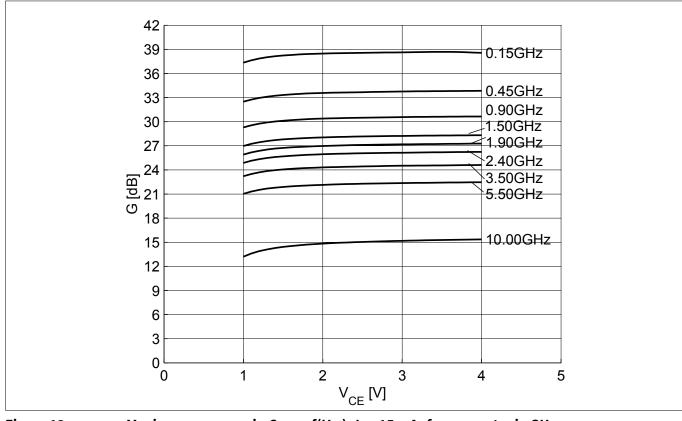
7



Electrical characteristics





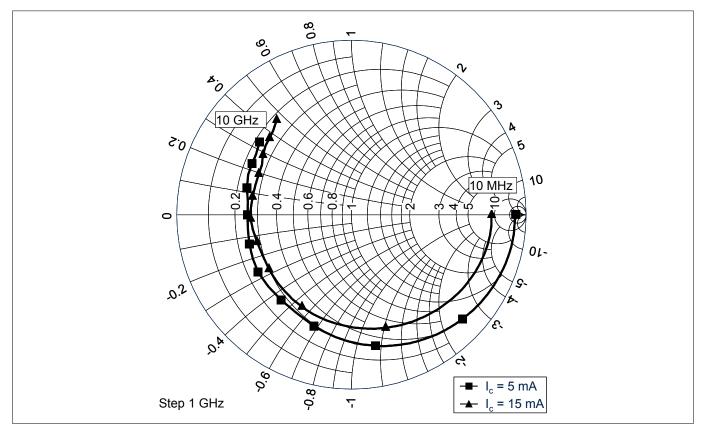




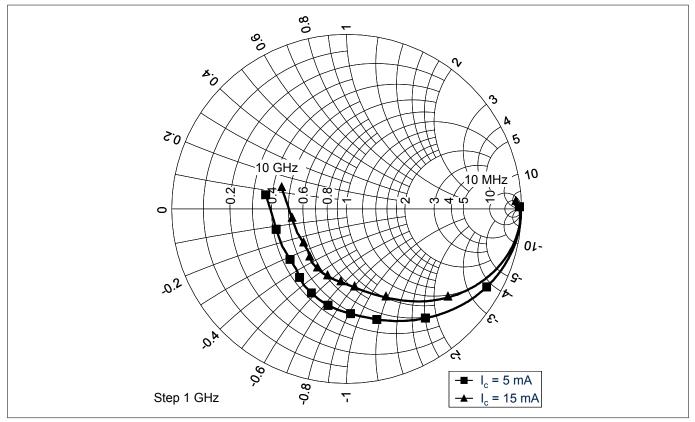
Maximum power gain $G_{max} = f(V_{CE})$, $I_C = 15$ mA, f = parameter in GHz



Electrical characteristics





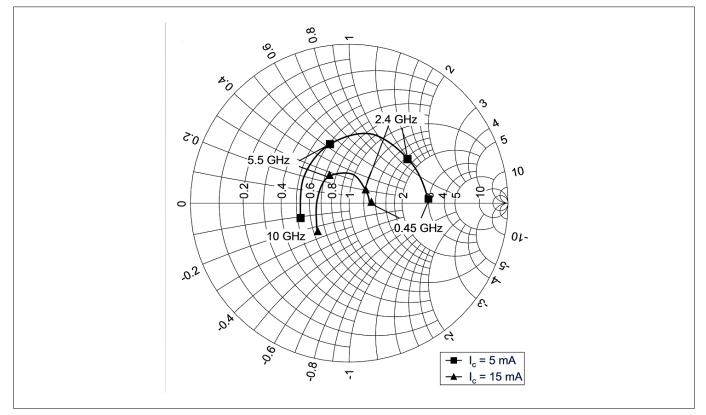




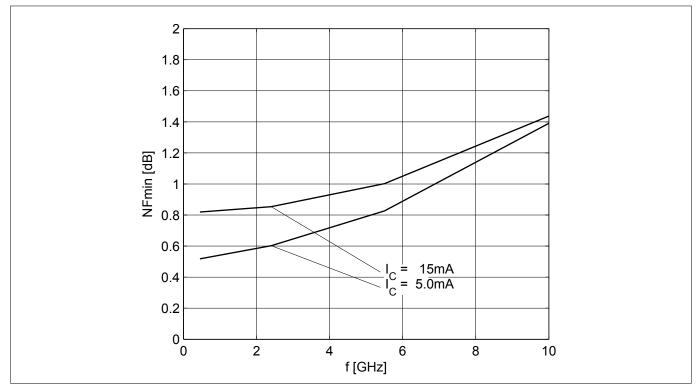
Output reflection coefficient S₂₂ = f(f), V_{CE} = 3 V, I_C = 5 / 15 mA



Electrical characteristics







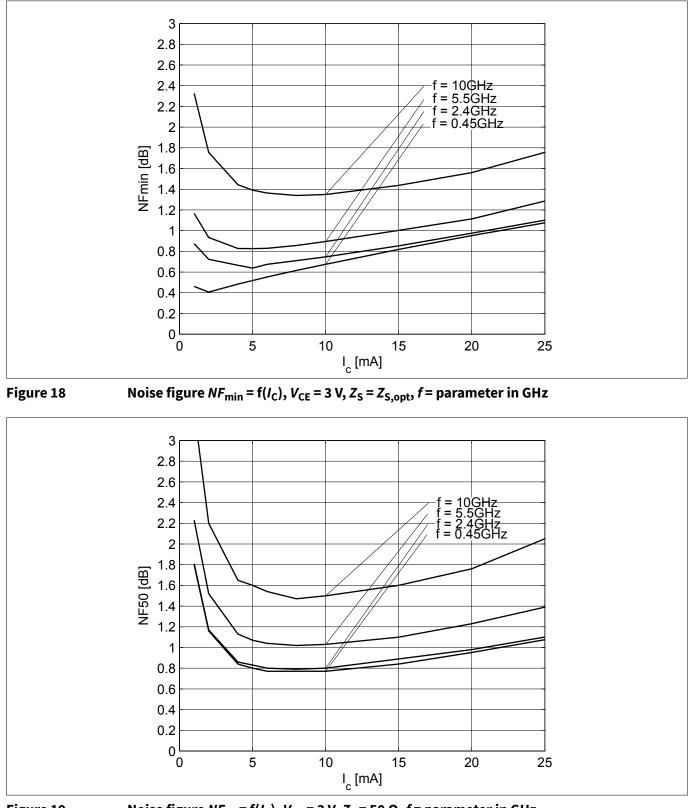


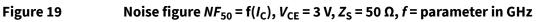
Noise figure $NF_{min} = f(f)$, $V_{CE} = 3 V$, $Z_S = Z_{S,opt}$, $I_C = 5 / 15 mA$

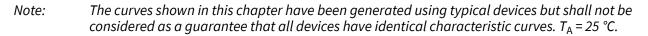
Datasheet



Electrical characteristics



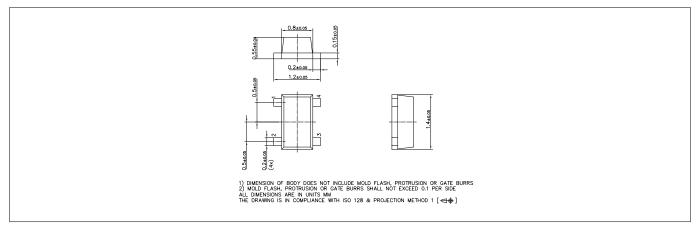




Package information TSFP-4-1



4 Package information TSFP-4-1





Package outline

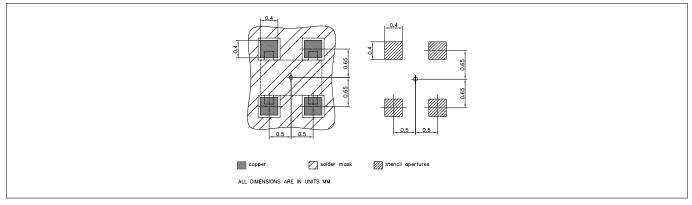


Figure 21 Foot print

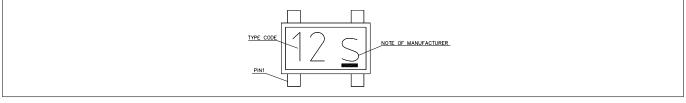


Figure 22 Marking layout example

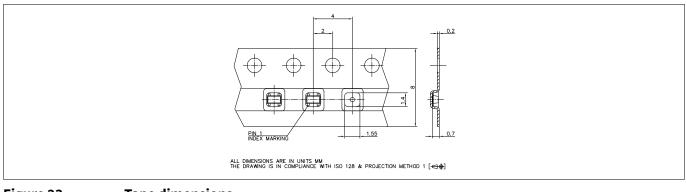


Figure 23 Tape dimensions

Revision history



Revision history

Document version	Date of release	Description of changes
2.0	2018-09-26	New datasheet layout.

Trademarks

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